

Form PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR INFORMATION DISCLOSURE STATEMENT
(Use Several Sheets if Necessary)

APPLICANT: Philippe Lance et al.

ATTY. DOCKET #: SC0862ET

FILING DATE: Concurrently Herewith

APPL. #: Unknown

GROUP: Unknown

10378 U.S. PTO
09/934159

08/21/01

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
dt	AA	5,829,879	11/3/98	Sanchez et al.	374	178	12/23/96
dt	AB	5,201,841	4/13/93	Lebeau et al.	364	5	2/20/92
dt	AC	5,237,481	8/17/93	Soo et al.	361	103	5/29/91
dt	AD	3,868,508	2/25/75	Lloyd	250	330	10/30/73
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION DATE (#43)	COUNTRY	CLASS	SUBCLASS
dt	AL	WO 98/34101	8/6/98	PCT	G01N	25/72
dt	AM	WO 00/40985	7/13/00	PCT	G01R	31/309
	AN					
	AO					
	AP					

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

dt	AR	EP 00402329 European Search Report, 3 pgs.	3/22/01
dt	AS	Kallis, "Nondestructive Infrared Inspection of Hybrid Microcircuit Substrate-to-Packge Thermal Adhesive Bonds," IEEE Transactions on Components, Hybrids, and Manufacturing Technology, Vol. CHMT-4, No. 3, September 1981, 4 pp.	
	AT		
	AU		
	AV		
	AW		
	AX		
	AY		
	AZ		

EXAMINER
Small M. J.

DATE CONSIDERED
1/10/03

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Substitute for form 1449A/PTO		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Application Number	09/934,159
		Filing Date	August 21, 2001
		First Named Inventor	Philippe Lance <i>et al.</i>
		Group Art Unit	2829
		Examiner Name	Emily Y. Chan
		Attorney Docket Number	SC0862ET
Sheet	1	of	

U. S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
BA	BA	5,477,076		Gay <i>et al.</i>	12/19/1995	257 / 467

FOREIGN PATENT DOCUMENTS								
Examiner Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Office ³	Number ⁴	Kind Code ² (if known)				

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		T ²

Examiner Signature	Donald M. Lai	Date Considered	1/10/03
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation, if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² See Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English Language Translation is attached.